Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,373	THOMPSON, RICHARD JOHN	
Examiner	Art Unit	
David E. Bochna	3679	

David E. Bochna

SEARCHED				
Class	Subclass	Date	Examiner	
285	149.1	9/25/2007	DB	
	154.1			
	368			
	412			
	- 151.1			
	424			
	370			
138	92			
	155			
174	68.3			
	101			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

(INCLUDING SEARCH STRATEGY)		
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